


<b>Search Notes</b> 	<b>Application/Control No.</b> 10540040	<b>Applicant(s)/Patent Under Reexamination</b> CROWLEY ET AL.
	<b>Examiner</b> Jaisle, Cecilia M	<b>Art Unit</b> 1624

SEARCHED			
Class	Subclass	Date	Examiner
544	279	9/12/2006	Cecilia Jaisle

SEARCH NOTES		
Search Notes	Date	Examiner
STN search by STIC	9/12/2006	Cecilia Jaisle

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner